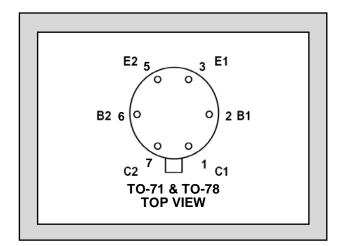


Improved Standard Products®

LS358

LOG CONFORMANCE MONOLITHIC DUAL PNP TRANSISTORS

FEATURES					
LOG CONFORMANCE	∆re ≤1Ω from ideal TYP.				
ABSOLUTE MAXIMUM RATINGS NOTE 1 (T _A = 25°C unless otherwise noted)					
Ic Collector-Current -10mA					
Maximum Temperatures					
Storage Temperature Range			-65°C to +150°C		
Operating Junction Temperature			-55°C to +150°C		
Maximum Power Dissipation	ONE S	SIDE	BOTH SIDES		
Device Dissipation T _A =25°C	250m	ıW	500mW		
Linear Derating Factor	2.3m	W/°C	4.3mW/°C		

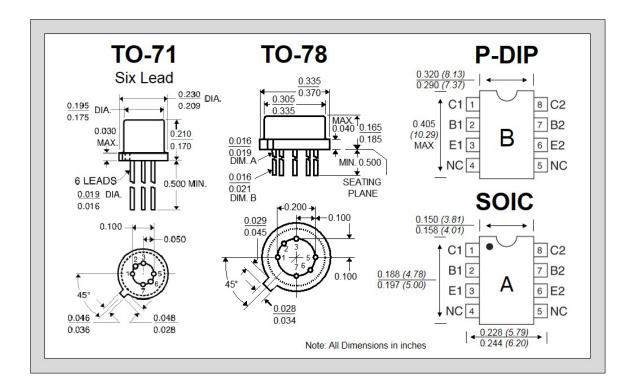


ELECTRICAL CHARACTERISTICS @ 25°C (unless otherwise noted)

SYMBOL	CHARACTERISTIC	LS358		UNITS	CONDITIONS
Δre	Log Conformance	1.5		Ω	Ic = -10-100-1000μA
BV _{CBO}	Collector-Base Breakdown Voltage	-20	MIN.	V	$I_C = -10\mu A$ $I_E = 0A$
BV _{CEO}	Collector to Emitter Voltage	-20	MIN.	V	$I_C = -1mA$ $I_B = 0A$
BV _{EBO}	Emitter-Base Breakdown Voltage	-6.0	MIN.	V	$I_E = -10\mu A$ $I_C = 0A$ NOTE 2
BVcco	Collector to Collector Voltage	45	MIN.	V	$I_C = \pm 10 \mu A$, $I_B = I_E = 0 A$
h _{FE}	DC Current Gain	100	MIN.		$I_C = -10\mu A$ $V_{CE} = -5V$
		600	MAX.		
h _{FE}	DC Current Gain	100	MIN.		$I_{C} = -100 \mu A$ $V_{CE} = -5 V$
		600	MAX.		
h _{FE}	DC Current Gain	100	MIN.		Ic = -1mA
V _{CE} (SAT)	Collector Saturation Voltage	-0.5	MAX.	V	$I_C = -1mA$ $I_B = -0.1mA$
Ісво	Collector Cutoff Current	-0.2	MAX.	nA	I _E = 0A V _{CB} = -15V
I _{EBO}	Emitter Cutoff Current	-0.2	MAX.	nA	$I_C = 0A$ $V_{EB} = -3V$
Сово	Output Capacitance ⁴	2.0	MAX.	pF	$I_E = 0A$ $V_{CB} = -5V$
C _{C1C2}	Collector to Collector Capacitance ⁴	2.0	MAX.	pF	Vcc = 0V
I _{C1C2}	Collector to Collector Leakage Current	±0.5	MAX.	μΑ	$V_{CC} = \pm 45V$ $I_B = I_E = 0A$
f⊤	Current Gain Bandwidth Product⁴	200	MIN.	MHz	$I_C = -1 \text{mA}$ $V_{CE} = -5 \text{V}$
NF	Narrow Band Noise Figure ⁴	3.0	MAX.	dB	$I_C = -100 \mu A$ $V_{CE} = -5V$ $BW = 200 Hz$ $R_G = 10 K\Omega$ $f=1 KHz$

MATCHING CHARACTERISTICS @ 25°C (unless otherwise noted)

SYMBOL	CHARACTERISTIC	LS358		UNITS	CONDITIONS
V _{BE1} -V _{BE2}	Base Emitter Voltage Differential	0.4	TYP.	mV	$I_C = -10 \mu A$ $V_{CE} = -5V$
		1	MAX.	mV	
Δ (V _{BE1} -V _{BE2)} /°C	Base Emitter Voltage Differential ⁴	1	TYP.	μV/°C	$I_C = -10 \mu A$ $V_{CE} = -5V$
	Change with Temperature				$T_A = -55^{\circ}C$ to $+125^{\circ}C$
I _{B1} -I _{B2}	Base Current Differential	5	MAX.	nA	$I_C = -10 \mu A$ $V_{CE} = -5V$
Δ (I _{B1} -I _{B2}) /°C	Base Current Differential ⁴	0.5	TYP.	nA/°C	$I_C = -10 \mu A$ $V_{CE} = -5V$
	Change with Temperature				$T_A = -55^{\circ}C$ to $+125^{\circ}C$
h _{FE1} /h _{FE2}	DC Current Gain Differential	5	TYP.	%	$I_{C} = -10 \ \mu A$ $V_{CE} = -5 V$



NOTES:

- 1. These ratings are limiting values above which the serviceability of any semiconductor may be impaired.
- 2. The reverse base-to-emitter voltage must never exceed 6.0 volts; the reverse base-to-emitter current must never exceed 10 µA.
- 3. All MIN/TYP/MAX Limits are absolute values. Negative signs indicate electrical polarity only.
- 4. Not tested; guaranteed by design.

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